

General Description

The 9LRS4206 is a low power CK505-compliant clock specification. This clock synthesizer provides a single chip solution for Intel processors and Intel chipsets. The 9LRS4206 is driven with a 14.318MHz crystal.

Recommended Application

Low Power CK505 Compliant Main Clock

Output Features

- 1 - 0.8V push-pull differential CPU pair
- 1 - 0.8V push-pull differential PCIEX pair
- 1 - 0.8V push-pull differential SATA pair
- 1 - 0.8V push-pull differential DOT96 pair
- 1 - USB, 48MHz
- 1 - REF, 14.318MHz

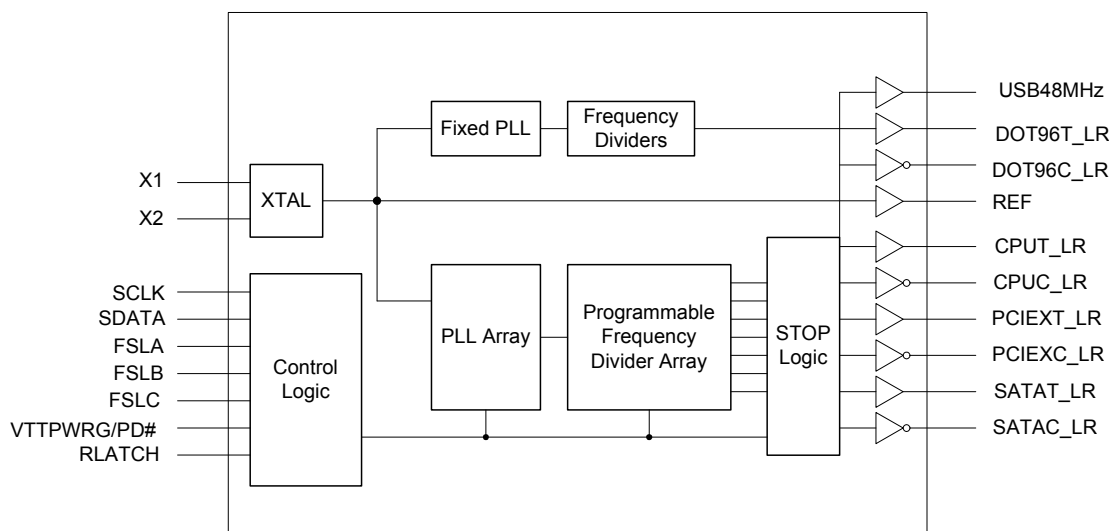
Features/Benefits

- Supports tight ppm accuracy clocks for Serial-ATA and PCIEX
- Supports programmable spread percentage and frequency
- Uses external 14.318MHz crystal, external crystal load caps are required for frequency tuning
- Low power differential clock outputs (No 50Ω resistor to GND needed)
- Integrated 33Ω series resistor on all differential outputs
- Meets PCIEX Gen2 Specification

Key Specifications

- CPU outputs cycle-cycle jitter < 85ps
- PCIEX outputs cycle-cycle jitter < 125ps
- SATA outputs cycle-cycle jitter < 125ps
- ±100ppm frequency accuracy on CPU, PCIEX and SATA clocks
- ±100ppm frequency accuracy on USB clocks

Block Diagram



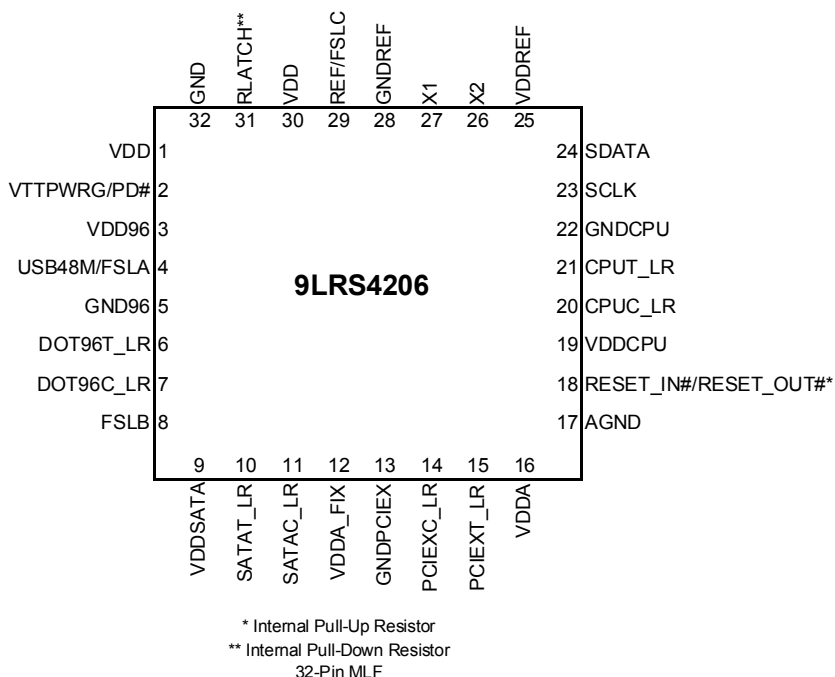
Preferred drive strengths using CK505 clock sources.

Transmission lines to load do not share series resistors.

Desktop (Zo=50Ω) and mobile (Zo=55Ω) have the same drive strength.

D.C.Drive Strength	Number of Loads to Drive	Match Point for N & P Voltage / Current (mA)	Number of Loads Actually Driven.		
			1 Load Rs =	2 Loads Rs=	3 Loads Rs =
	1	0.56 / 33 (17Ω)	33Ω [39Ω]	-	-
	2	0.92 / 66 (14Ω)	39Ω [43Ω]	22Ω [27Ω]	-
	3	1.15 / 99 (11.6Ω)	43Ω [43Ω]	27Ω [33Ω]	15Ω [22Ω]

Pin Configuration



Functionality Table

FS _L C (B0b2)	FS _L B (B0b1)	FS _L A (B0b0)	CPU MHz	PCIEX MHz	SATA MHz	DOT96 MHz
0	0	1	133.33	100.00	100.00	96.00
1	0	1	100.00	100.00	100.00	96.00

CPU/PCIEX PLL Spread Frequency Selection Table

FS _L C (B0b2)	FS _L B (B0b1)	FS _L A (B0b0)	CPU MHz	PCIEX MHz	SATA MHz	Spread % (B0b5=1)
0	0	1	133.33	100.00	100.00	0.5% Down
1	0	1	100.00	100.00	100.00	0.5% Down

Power Management Table

PD#	SMBus Register OE	CPUT/C	PCIEXT/C	DOT96T/C	SATAT/C	48M	REF
1	Enable	Running	Running	Running	Running	Running	Running
0	Enable	Low	Low	Low	Low	Low	Low
1	Disable	Low	Low	Low	Low	Low	Low

9LRS4206 Power Distribution Table

VDD Pin#	GND Pin#	Description
1	5	CPU PLL digital
3	5	48MHz output
9	13	SATACLK output
12	5	Fix PLL analog
16	17	CPU PLL core; PCIEX output; CPU PLL analog
19	22	CPUCLK output
25	28	Fix PLL digital; REF output
30	32	Fix PLL core

Pin Descriptions

PIN #	PIN NAME	TYPE	DESCRIPTION
1	VDD	PWR	Power supply, nominal 3.3V
2	VTPWVRG/PD#	IN	This active high 3.3V LVTTTL input is a level sensitive strobe used to determine when latch inputs are valid and are ready to be sampled / Asynchronous active low input pin that is used to power down the device into low power state.
3	VDD96	PWR	Power supply for DOT96 outputs.
4	USB48M/FSLA	I/O	3.3V tolerant input for CPU frequency selection. Refer to input electrical characteristics for Vil_FS and Vih_FS values / Fixed 3.3V 48MHz USB clock output.
5	GND96	PWR	Ground pin for DOT96 outputs.
6	DOT96T_LR	OUT	True clock of DOT 96MHz low power differential output pair with integrated 33ohm series resistor and no 50ohm to GND needed
7	DOT96C_LR	OUT	Complement clock of DOT 96MHz low power differential output pair with integrated 33ohm series resistor and no 50ohm to GND needed
8	FSLB	IN	3.3V tolerant input for CPU frequency selection. Refer to input electrical characteristics for Vil_FS and Vih_FS values.
9	VDDSAATA	PWR	Power supply for SATA clocks, nominal 3.3V
10	SATAT_LR	OUT	True clock of 0.8V push-pull differential SATA pair with integrated 33ohm series resistor and no 50ohm to GND needed
11	SATAC_LR	OUT	Complement clock of 0.8V push-pull differential SATA pair with integrated 33ohm series resistor and no 50ohm to GND needed
12	VDDA_FIX	PWR	Power supply for FIX PLL Analog, nominal 3.3V.
13	GNDPCIEEX	PWR	Ground pin for PCIEEX outputs.
14	PCIEXC_LR	OUT	Complement clock of 0.8V differential push-pull PCI_Express pair with integrated 33ohm series resistor and no 50ohm to GND needed
15	PCIEXT_LR	OUT	True clock of 0.8V differential push-pull PCI_Express pair with integrated 33ohm series resistor and no 50ohm to GND needed
16	VDDA	PWR	3.3V power for the PLL core.
17	AGND	PWR	Ground pin for the PLL core.
18	RESET_IN#/RESET_OUT#*	I/O	Real time active low input. When active, SMBus is reset to power up default / Real time system reset signal for frequency gear ratio change or watchdog timer timeout. This signal is active low.
19	VDDCPU	PWR	Supply for CPU clocks, 3.3V nominal
20	CPUC_LR	OUT	Complementary clock of differential pair 0.8V push-pull CPU outputs with integrated 33ohm series resistor and no 50ohm to GND needed
21	CPUT_LR	OUT	True clock of differential pair 0.8V push-pull CPU outputs with integrated 33ohm series resistor and no 50ohm to GND needed
22	GNDCPU	PWR	Ground pin for CPU outputs.
23	SCLK	IN	Clock pin of SMBus circuitry, 3.3V tolerant.
24	SDATA	I/O	Data pin for SMBus circuitry, 3.3V tolerant.
25	VDDREF	PWR	Ref, XTAL power supply, nominal 3.3V
26	X2	OUT	Crystal output, Nominally 14.318MHz
27	X1	IN	Crystal input, Nominally 14.318MHz.
28	GNDREF	PWR	Ground for REF outputs.
29	REF/FSLC	I/O	14.318 MHz reference clock./ 3.3V tolerant input for CPU frequency selection. Refer to input electrical characteristics for Vil_FS and Vih_FS values.
30	VDD	PWR	Power supply, nominal 3.3V
31	RLATCH**	IN	Asynchronous input pin used in combination with VTPWVRGD signal to determine whether to reset SMBus.
32	GND	PWR	Ground pin.

Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the 9LRS4206. These ratings, which are standard values for IDT commercially rated parts, are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	Notes
Maximum Supply Voltage	VDDxxx	Core/Logic Supply		4.6	V	1,2
Maximum Input Voltage	V _{IH}	3.3V LVCMOS Inputs		4.6	V	1,2,3
Minimum Input Voltage	V _{IL}	Any Input	GND - 0.5		V	1,2
Storage Temperature	T _s	-	-65	150	°C	1,2
Case Temperature	T _{case}	-		115	°C	1,2
Input ESD protection	ESD prot	Human Body Model	2000		V	1,2

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

² Operation under these conditions is neither implied, nor guaranteed.

³ Maximum input voltage is not to exceed maximum VDD

Electrical Characteristics—Input/Supply/Common Output Parameters

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	Notes
Ambient Operating Temp	T _{ambient}	-	0	70	°C	
Supply Voltage	VDDxxx	Supply Voltage	3.135	3.465	V	
Input High Voltage	V _{IHSE}	Single-ended inputs	2	V _{DD} + 0.3	V	1,4
Input Low Voltage	V _{ILSE}	Single-ended inputs	V _{SS} - 0.3	0.8	V	1,4
Low Threshold Input-High Voltage	V _{IH_FS}	3.3 V +/-5%	0.7	VDD+0.3	V	1
Low Threshold Input-Low Voltage	V _{IL_FS}	3.3 V +/-5%	V _{SS} - 0.3	0.35	V	1
Input Leakage Current	I _{IN}	V _{IN} = V _{DD} , V _{IN} = GND	-5	5	uA	1,3
Input Leakage Current	I _{INRES}	Inputs with pull or pull down resistors V _{IN} = V _{DD} , V _{IN} = GND	-200	200	uA	1
Output High Voltage	V _{OHSE}	Single-ended outputs, I _{OH} = -1mA	2.4		V	1,2
Output Low Voltage	V _{OLSE}	Single-ended outputs, I _{OL} = 1 mA		0.4	V	1,2
Operating Supply Current	I _{DDOP3.3}	Full Active, C _L = Full load; IDD 3.3V		125	mA	1
Powerdown Current	I _{DDPD3.3}	Power down mode, 3.3V Rail		5	mA	1
Input Frequency	F _i	V _{DD} = 3.3 V		15	MHz	1
Pin Inductance	L _{pin}			7	nH	1
Input Capacitance	C _{IN}	Logic Inputs	1.5	5	pF	1
	C _{OUT}	Output pin capacitance		6	pF	1
	C _{INX}	X1 & X2 pins		6	pF	1
Spread Spectrum Modulation Frequency	f _{SSMOD}	Triangular Modulation	30	33	kHz	1

*TA = 0 - 70°C; Supply Voltage VDD = 3.3 V +/-5%

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

² Signal is required to be monotonic in this region.

³ Input leakage current does not include inputs with pull-up or pull-down resistors

⁴ 3.3V referenced inputs are: RESET_IN, RLATCH, SCLK, SDATA, VTTWRGD inputs if selected.

Electrical Characteristics–SMBus Interface

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	Notes
SMBus Voltage	V_{DD}		2.7	5.5	V	1
Low-level Output Voltage	V_{OLSMB}	@ I_{PULLUP}		0.4	V	1
Current sinking at $V_{OLSMB} = 0.4$ V	I_{PULLUP}	SMB Data Pin	4		mA	1
SCLK/SDATA Clock/Data Rise Time	T_{RI2C}	(Max $V_{IL} - 0.15$) to (Min $V_{IH} + 0.15$)		1000	ns	1
SCLK/SDATA Clock/Data Fall Time	T_{FI2C}	(Min $V_{IH} + 0.15$) to (Max $V_{IL} - 0.15$)		300	ns	1
Maximum SMBus Operating Frequency	F_{SMBUS}	Block Mode		100	kHz	1

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

AC Electrical Characteristics–Input/Common Parameters

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	Notes
Clk Stabilization	T_{STAB}	From VDD Power-Up or de-assertion of PD# to 1st clock		1.8	ms	1
Tdrive_PD#	T_{DRPD}	Differential output enable after PD# de-assertion		300	us	1
Tfall_PD#	T_{FALL}	Fall/Rise time of PD# input		5	ns	1
Trise_PD#	T_{RISE}			5	ns	1

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

AC Electrical Characteristics–Low Power Differential Outputs

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	NOTES
Rising Edge Slew Rate	t_{SLR}	Differential Measurement	2.5	4	V/ns	1,3,4
Falling Edge Slew Rate	t_{FLR}	Differential Measurement	2.5	4	V/ns	1,3,4
Slew Rate Variation	t_{SLVAR}	Single-ended Measurement		20	%	1,2,7
Differential Voltage Swing	V_{SWING}	Single-ended Measurement			mV	1,3
Crossing Point Voltage	V_{XABS}	Single-ended Measurement	300	550	mV	1,2,5,6
Crossing Point Variation	$V_{XABSVAR}$	Single-ended Measurement		140	mV	1,2,5,10
Maximum Output Voltage	V_{HIGH}	Includes overshoot		1150	mV	1,2,8
Minimum Output Voltage	V_{LOW}	Includes undershoot	-300		mV	1,2,9
Duty Cycle	D_{CYC}	Differential Measurement	45	55	%	1,3

*TA = 0 - 70°C; Supply Voltage VDD = 3.3 V +/-5%, Rs=0ohm, CL=2pF

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

² Measurement taken for single ended waveform on a component test board (not in system)

³ Measurement taken from differential waveform on a component test board. (not in system)

⁴ Slew rate emasured through V_{swing} voltage range centered about differential zero

⁵ Vcross is defined at the voltage where Clock = Clock#, measured on a component test board (not in system)

⁶ Only applies to the differential rising edge (Clock rising, Clock# falling)

⁷ Matching applies to rising edge rate for Clock and falling edge rate for Clock#. It is measured using a +/-75mV window centered on the average cross point where Clock rising meets Clock# falling. The median cross point is used to calculate the voltage

⁸ The max voltage including overshoot.

⁹ The min voltage including undershoot.

¹⁰ The total variation of all Vcross measurements in any particular system. Note this is a subset of V_{cross} min/mas (V_{Cross} absolute) allowed. The intent is to limit Vcross induced modulation by setting C_{cross_delta} to be smaller than V_{Cross} absolute.

Electrical Characteristics–USB48MHz

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	NOTES
Long Accuracy	ppm	see Tperiod min-max values	-100	100	ppm	1,2,6
Clock period	T _{period}	48.00MHz output nominal	20.83125	20.83542	ns	1,4,5
Absolute min/max period	T _{abs}	48.00MHz output nominal	20.48130	21.18540	ns	1,4
CLK High Time	T _{HIGH}		8.216563	11.152	ns	1
CLK Low time	T _{LOW}		7.816563	10.952	ns	1
Output High Voltage	V _{OH}	I _{OH} = -1 mA	2.4		V	1
Output Low Voltage	V _{OL}	I _{OL} = 1 mA		0.55	V	1
Output High Current	I _{OH}	V _{OH} @MIN = 1.0 V	-29		mA	1
		V _{OH} @MAX = 3.135 V		-23	mA	1
Output Low Current	I _{OL}	V _{OL} @ MIN = 1.95 V	29		mA	1
		V _{OL} @ MAX = 0.4 V		27	mA	1
Rising Edge Slew Rate	t _{SLR}	Measured from 0.8 to 2.0 V	1	2	V/ns	1,3
Falling Edge Slew Rate	t _{FLR}	Measured from 2.0 to 0.8 V	1	2	V/ns	1,3
Duty Cycle	d _{tt}	V _T = 1.5 V	45	55	%	1,4
Jitter, Cycle to cycle	t _{cy-cyc}	V _T = 1.5 V		350	ps	1,4

*TA = 0 - 70°C; Supply Voltage VDD = 3.3 V +/-5%, Rs=33ohm, CL=5pF

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

² All Long Term Accuracy and Clock Period specifications are guaranteed assuming that REFOUT is at 14.31818MHz

³ Edge rate in system is measured from 0.8V to 2.0V.

⁴ Duty cycle, Period and Jitter are measured with respect to 1.5V

⁵ The average period over any 1us period of time

⁶ Using frequency counter with the measurement interval equal or greater than 0.15s. Target frequencies are 14.318181 MHz and 48.000000MHz

Electrical Characteristics–REF-14.318MHz

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	Notes
Long Accuracy	ppm	see Tperiod min-max values	-100	100	ppm	1,2,6
Clock period	T _{period}	14.318MHz output nominal	69.8203	69.8622	ns	1,4,5
Absolute min/max period	T _{abs}	14.318MHz output nominal	69.8203	70.86224	ns	1,4
CLK High Time	T _{HIGH}		29.97543	38.46654	ns	1
CLK Low time	T _{LOW}		29.57543	38.26654	ns	1
Output High Voltage	V _{OH}	I _{OH} = -1 mA	2.4		V	1
Output Low Voltage	V _{OL}	I _{OL} = 1 mA		0.4	V	1
Output High Current	I _{OH}	V _{OH} @MIN = 1.0 V, V _{OH} @MAX = 3.135 V	-33	-33	mA	1
		V _{OL} @MIN = 1.95 V, V _{OL} @MAX = 0.4 V	30	38	mA	1
Rising Edge Slew Rate	t _{SLR}	Measured from 0.8 to 2.0 V	1	4	V/ns	1,3
Falling Edge Slew Rate	t _{FLR}	Measured from 2.0 to 0.8 V	1	4	V/ns	1,3
Duty Cycle	d _{tt}	V _T = 1.5 V	45	55	%	1,4
Jitter	t _{cy-cyc}	V _T = 1.5 V		1000	ps	1,4

*TA = 0 - 70°C; Supply Voltage VDD = 3.3 V +/-5%, Rs=33ohm, CL=5pF

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

² All Long Term Accuracy and Clock Period specifications are guaranteed assuming that REFOUT is at 14.31818MHz

³ Edge rate in system is measured from 0.8V to 2.0V.

⁴ Duty cycle, Period and Jitter are measured with respect to 1.5V

⁵ The average period over any 1us period of time

⁶ Using frequency counter with the measurement interval equal or greater than 0.15s. Target frequencies are 14.318181 MHz and 48.000000MHz

Clock Jitter Specifications - Low Power Differential Outputs

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNITS	NOTES
CPU Jitter - Cycle to Cycle	CPUJ _{C2C}	Differential Measurement		85	ps	1,2
SRC Jitter - Cycle to Cycle	SRCJ _{C2C}	Differential Measurement		125	ps	1,2,3
SATA Jitter - Cycle to Cycle	SATAJ _{C2C}	Differential Measurement		125	ps	1,2
DOT Jitter - Cycle to Cycle	DOTJ _{C2C}	Differential Measurement		250	ps	1,2
SRC Phase Jitter	t _{jphasePLL}	PCIe Gen 1		86	ps (p-p)	1,2
	t _{jphaseLo}	PCIe Gen 2 10kHz < f < 1.5MHz		3.0	ps (RMS)	1,4
	t _{jphaseHigh}	PCIe Gen 2 1.5MHz < f < Nyquist (50MHz)		3.1	ps (RMS)	1,4

*TA = 0 - 70°C; Supply Voltage VDD = 3.3 V +/-5%, Rs=0ohm, CL=2pF

¹ Unless otherwise noted, guaranteed by design and characterization, not 100% tested in production.

² Jitter specs are specified as measured on a clock characterization board. System designers need to take special care not to use these numbers, as the in-system performance will be somewhat degraded.

³ Phase jitter requirement: The designated Gen2 outputs will meet the reference clock jitter requirements from the PCI Express Gen2 Base Spec. The test is performed on a component test board under quiet conditions with all outputs on.

⁴ See <http://www.pcisig.com> for complete specs

How to Write

- Controller (host) sends a start bit
- Controller (host) sends the write address
- IDT clock will **acknowledge**
- Controller (host) sends the beginning byte location = N
- IDT clock will **acknowledge**
- Controller (host) sends the byte count = X
- IDT clock will **acknowledge**
- Controller (host) starts sending Byte **N through Byte N+X-1**
- IDT clock will **acknowledge** each byte **one at a time**
- Controller (host) sends a Stop bit

Index Block Write Operation			
Controller (Host)			IDT (Slave/Receiver)
T	starT bit		
Slave Address			
WR	WRIte		
			ACK
Beginning Byte = N			
			ACK
Data Byte Count = X			
			ACK
Beginning Byte N			X Byte
		ACK	
O		O	
O		O	
O		O	
		O	
Byte N + X - 1			
			ACK
P	stoP bit		

Read Address	Write Address
D3 _(H)	D2 _(H)

- Controller (host) will send a start bit
- Controller (host) sends the write address
- IDT clock will **acknowledge**
- Controller (host) sends the beginning byte location = N
- IDT clock will **acknowledge**
- Controller (host) will send a separate start bit
- Controller (host) sends the read address
- IDT clock will **acknowledge**
- IDT clock will send the data byte count = X
- IDT clock sends Byte **N+X-1**
- IDT clock sends **Byte 0 through Byte X (if $X_{(H)}$ was written to Byte 8)**
- Controller (host) will need to acknowledge each byte
- Controller (host) will send a not acknowledge bit
- Controller (host) will send a stop bit

Index Block Read Operation		
Controller (Host)		IDT (Slave/Receiver)
T	starT bit	
Slave Address		
WR	WRite	
		ACK
Beginning Byte = N		
		ACK
RT	Repeat starT	
Slave Address		
RD	ReaD	
		ACK
		Data Byte Count=X
ACK		
		Beginning Byte N
ACK		
		O
O		O
O		O
O		
		Byte N + X - 1
N	Not acknowledge	
P	stoP bit	

I2C Table: Frequency Select Register

Byte 0	Name	Control Function	Type	0	1	PWD
Bit 7	ROD	Reset on Demand	RW	Disable	Enable	0
Bit 6	Reserved	Reserved	RW	-	-	1
Bit 5	SS_EN	CPU/PCIEX PLL Spread Enable	RW	OFF	ON	1
Bit 4	Reserved	Reserved	RW	-	-	1
Bit 3	Reserved	Reserved	RW	-	-	0
Bit 2	FSLC	Freq Select Bit 2	RW	See Table 1: CPU/PCIEX PLL Frequency Selection Table		Latch
Bit 1	FSLB	Freq Select Bit 1	RW			Latch
Bit 0	FSLA	Freq Select Bit 0	RW			Latch

I2C Table: Output Control Register

Byte 1	Name	Control Function	Type	0	1	PWD
Bit 7	DOT96T/C	Output Control	RW	Disable	Enable	1
Bit 6	Reserved	Reserved	RW	-	-	1
Bit 5	RLATCH	RLATCH pin enable bit (Enables pin to be active)	RW	Disable	Enable	1
Bit 4	Reserved	Reserved	RW	-	-	0
Bit 3	RESET_IN_EN	RESET_IN Enable	RW	Disable	Enable	0
Bit 2	REF Strength	REF Strength Programming	RW	1X	2X	0
Bit 1	Reserved	Reserved	RW	-	-	0
Bit 0	CPU/PCIEX PLL MNEN	CPU/PCIEX PLL M/N Enable	RW	Disable	Enable	0

I2C Table: Output Control Register

Byte 2	Name	Control Function	Type	0	1	PWD
Bit 7	USB48M	Output Control	RW	Disable	Enable	1
Bit 6	Reserved	Reserved	RW	-	-	1
Bit 5	Reserved	Reserved	RW	-	-	1
Bit 4	Reserved	Reserved	RW	-	-	1
Bit 3	Reserved	Reserved	RW	-	-	1
Bit 2	Reserved	Reserved	RW	-	-	0
Bit 1	Reserved	Reserved	RW	-	-	0
Bit 0	Reserved	Reserved	RW	-	-	0

I2C Table: Output Control Register

Byte 3	Name	Control Function	Type	0	1	PWD
Bit 7	Reserved	Reserved	RW	-	-	1
Bit 6	Reserved	Reserved	RW	-	-	1
Bit 5	PCIEXT/C	Output Control	RW	Disable	Enable	1
Bit 4	Reserved	Reserved	RW	-	-	1
Bit 3	Reserved	Reserved	RW	-	-	0
Bit 2	Reserved	Reserved	RW	-	-	0
Bit 1	SATAT/C	Output Control	RW	Disable	Enable	1
Bit 0	Reserved	Reserved	RW	-	-	1

I2C Table: Output Control Register

Byte 4	Name	Control Function	Type	0	1	PWD
Bit 7	Reserved	Reserved	RW	-	-	1
Bit 6	REF	Output Control	RW	Disable	Enable	1
Bit 5	Reserved	Reserved	RW	-	-	1
Bit 4	CPUT/C	Output Control	RW	Disable	Enable	1
Bit 3	Reserved	Reserved	RW	-	-	0
Bit 2	Reserved	Reserved	RW	-	-	1
Bit 1	Reserved	Reserved	RW	-	-	0
Bit 0	Reserved	Reserved	RW	-	-	0

Byte 5 Reserved Register

I2C Table: Output Control Register

Byte 6	Name	Control Function	Type	0	1	PWD
Bit 7	Diff AMP	CPU Differential output Amplitude Control	RW	00 = 700mV	01 = 900mV	1
Bit 6	Diff AMP		RW	10 = 800mV	11 = 1000mV	0
Bit 5	Reserved	Reserved	RW	-	-	0
Bit 4	Reserved	Reserved	RW	-	-	0
Bit 3	Diff AMP	DOT96 Differential output Amplitude Control	RW	00 = 700mV	01 = 900mV	1
Bit 2	Diff AMP		RW	10 = 800mV	11 = 1000mV	0
Bit 1	Reserved	Reserved	RW	-	-	1
Bit 0	Reserved	Reserved	RW	-	-	0

I2C Table: Revision and Vendor ID Register

Byte 7	Name	Control Function	Type	0	1	PWD
Bit 7	RID3	Revision ID	R	-	-	0
Bit 6	RID2		R	-	-	0
Bit 5	RID1		R	-	-	0
Bit 4	RID0		R	-	-	0
Bit 3	VID3	VENDOR ID	R	-	-	0
Bit 2	VID2		R	-	-	0
Bit 1	VID1		R	001 = ICS	-	0
Bit 0	VID0		R	-	-	1

I2C Table: Byte Count Register

Byte 8	Name	Control Function	Type	0	1	PWD
Bit 7	BC7	Byte Count Programming b(7:0)	R	Writing to this register will configure how many bytes will be read back, default is 0F = 15 bytes.		0
Bit 6	BC6		R			0
Bit 5	BC5		R			0
Bit 4	BC4		RW			0
Bit 3	BC3		RW			1
Bit 2	BC2		RW			1
Bit 1	BC1		RW			1
Bit 0	BC0		RW			1

I2C Table: Watch Dog Timer Control Register

Byte 9	Name	Control Function	Type	0	1	PWD
Bit 7	HWD_EN	Watchdog Hard Alarm Enable	RW	Disable	Enable	0
Bit 6	WD Hard Status	WD Hard Alarm Status	R	Normal	Alarm	X
Bit 5	WDTCtrl	Watch Dog Alarm Time base Control	RW	290ms Base	1160ms Base	0
Bit 4	HWD3	WD Hard Alarm Timer Bit 3	RW	These bits represent X*290ms or X*1.16s. The watchdog timer waits before it goes to alarm mode. Default is 15 X 290ms = 4.35s.		1
Bit 3	HWD2	WD Hard Alarm Timer Bit 2	RW			1
Bit 2	HWD1	WD Hard Alarm Timer Bit 1	RW			1
Bit 1	HWD0	WD Hard Alarm Timer Bit 0	RW			1
Bit 0	Reserved	Reserved	RW	-	-	0

I2C Table: Output Control Register

Byte 10	Name	Control Function	Type	0	1	PWD
Bit 7	Diff AMP	PCIEX Differential output Amplitude Control	RW	00 = 700mV	01 = 900mV	1
Bit 6	Diff AMP		RW	10 = 800mV	11 = 1000mV	0
Bit 5	Diff AMP	SATACLK Differential output Amplitude Control	RW	00 = 700mV	01 = 900mV	1
Bit 4	Diff AMP		RW	10 = 800mV	11 = 1000mV	0
Bit 3	Reserved	Reserved	RW	-	-	0
Bit 2	Reserved	Reserved	RW	-	-	0
Bit 1	Reserved	Reserved	RW	-	-	0
Bit 0	Reserved	Reserved	RW	-	-	0

Byte 11 Reserved Register

I2C Table: CPU/PCIEX PLL Frequency Control Register

Byte 12	Name	Control Function	Type	0	1	PWD
Bit 7	N Div8	N Divider Programming:	RW	The decimal representation of N Divider in Byte12 will configure the CPU/PCIEX PLL VCO frequency. Default at power up = latch-in or Byte 0 ROM table.		X
Bit 6	N Div7		RW			X
Bit 5	N Div6		RW			X
Bit 4	N Div5		RW			X
Bit 3	N Div4		RW			X
Bit 2	N Div3		RW			X
Bit 1	N Div2		RW			X
Bit 0	N Div1		RW			X

Byte 13 ~ 19 Reserved Registers

I2C Table: Output Control Register

Byte 20	Name	Control Function	Type	0	1	PWD
Bit 7	48MHz Strength	48MHz Strength Control	RW	1X	2X	0
Bit 6	Reserved	Reserved	RW	-	-	0
Bit 5	Reserved	Reserved	RW	-	-	X
Bit 4	Reserved	Reserved	RW	-	-	0
Bit 3	Reserved	Reserved	RW	-	-	X
Bit 2	SKIP_ORT	Skip ORT during CPU/SRC PLL M/N Programming	RW	ORT Enabled	ORT Disabled	0
Bit 1	Reserved	Reserved	RW	-	-	X
Bit 0	Reserved	Reserved	RW	-	-	X

I2C Table: Output Control Register

Byte 21	Name	Control Function	Type	0	1	PWD
Bit 7	USB48M	Slew Rate Control	RW	00 = 1.2V/ns	01 = 1.6V/ns	0
Bit 6	USB48M		RW	10 = 2.0V/ns	11 = 2.4V/ns	1
Bit 5	REF	Slew Rate Control	RW	00 = 1.2V/ns	01 = 1.6V/ns	1
Bit 4	REF		RW	10 = 2.0V/ns	11 = 2.4V/ns	1
Bit 3	Reserved	Reserved	RW	-	-	0
Bit 2	Reserved	Reserved	RW	-	-	1
Bit 1	Reserved	Reserved	RW	-	-	0
Bit 0	Reserved	Reserved	RW	-	-	0

I2C Table: Synchronization Control Register

Byte 22	Name	Control Function	Type	0	1	PWD
Bit 7	SATA_SSEL	SATACLK Source Select	RW	CPU PLL	FIX PLL	0
Bit 6	Reserved	Reserved	RW	-	-	0
Bit 5	Reserved	Reserved	RW	-	-	0
Bit 4	Reserved	Reserved	RW	-	-	0
Bit 3	Reserved	Reserved	RW	-	-	0
Bit 2	Reserved	Reserved	RW	-	-	0
Bit 1	Reserved	Reserved	RW	-	-	0
Bit 0	Reserved	Reserved	RW	-	-	0

Byte 23 ~ 27 Reserved Registers

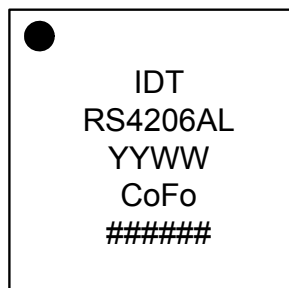
I2C Table: CPU Output Divider Register

Byte 28	Name	Control Function	Type	0	1	PWD
Bit 7	Reserved	Reserved	RW	-	-	X
Bit 6	Reserved	Reserved	RW	-	-	X
Bit 5	Reserved	Reserved	RW	-	-	X
Bit 4	Reserved	Reserved	RW	-	-	X
Bit 3	Reserved	Reserved	RW	-	-	X
Bit 2	CPUDiv2	CPU Divider Ratio Programming Bits for CPU PLL	RW	000:/2	011:/6	X
Bit 1	CPUDiv1		RW	001:/3	100:/8	X
Bit 0	CPUDiv0		RW	010:/4	101:/12	X

I2C Table: PCIeX Output Divider Register

Byte 29	Name	Control Function	Type	0	1	PWD
Bit 7	Reserved	Reserved	RW	-	-	X
Bit 6	Reserved	Reserved	RW	-	-	X
Bit 5	Reserved	Reserved	RW	-	-	X
Bit 4	Reserved	Reserved	RW	-	-	X
Bit 3	Reserved	Reserved	RW	-	-	X
Bit 2	PCIEXDiv2	PCIEX Divider Ratio Programming Bits for PCIeX PLL	RW	000:/4	010:/8	X
Bit 1	PCIEXDiv1		RW	001:/5	011:/10	X
Bit 0	PCIEXDiv0		RW	-	-	X

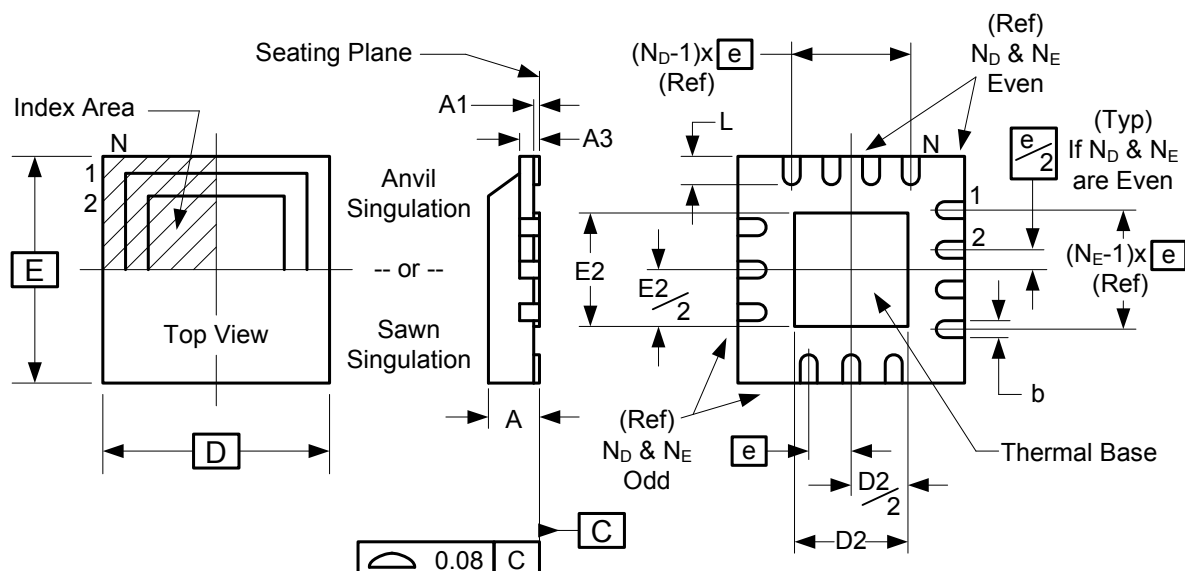
Marking Diagram



Notes:

1. Due to the package size constraints, actual top-side marking may differ from full orderable part number.
2. ##### is the lot number.
3. YYWW is the last two digits of the year and week that the part was assembled.
4. "L" denotes RoHS compliant package.

Package Outline and Package Dimensions (32-pin MLF)



Ordering Information

Part / Order Number	Marking	Shipping Packaging	Package	Temperature
9LRS4206AKLF	see page 13	Tubes	32-pin MLF	0 to +70° C
9LRS4206AKLFT		Tape and Reel	32-pin MLF	0 to +70° C

"LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

"A" is the device revision designator (will not correlate with the datasheet revision).

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Revision History

Rev.	Originator	Date	Description of Change
0.1	D.Chan	10/04/10	Initial release.
A	RDW	01/28/14	Moved to final per characterization data.

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Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu,
Koto-ku, Tokyo 135-0061, Japan
www.renesas.com

Contact Information

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